

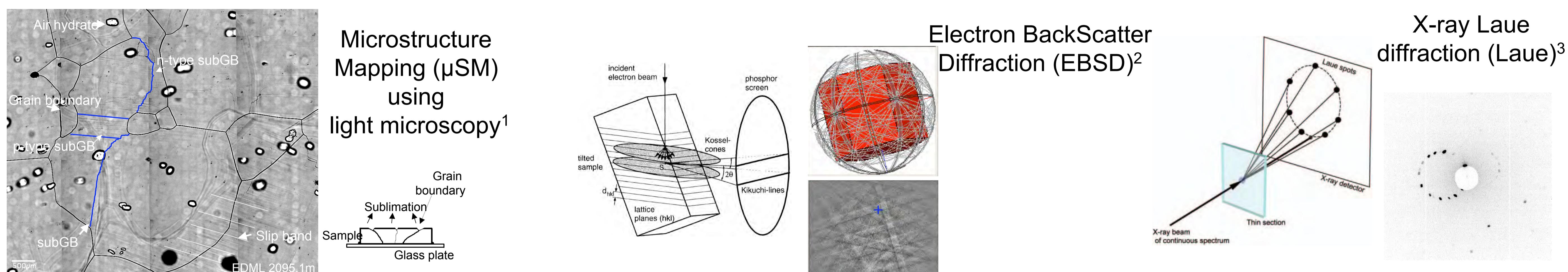
Dislocation Activity in Antarctic ice (EDML core)

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Introduction

As subgrain boundaries (subGB) are comprised of dislocations, orientation of subGB depends on the orientation of the locally active slip systems. Dislocation types can be determined by combined studies on orientation and misorientation (MO) geometries of subGB. SubGB are characterized by (1) orientation within the crystal, (2) MO angle and (3) MO rotation axis.

Methods



Laue Results and Interpretation⁴

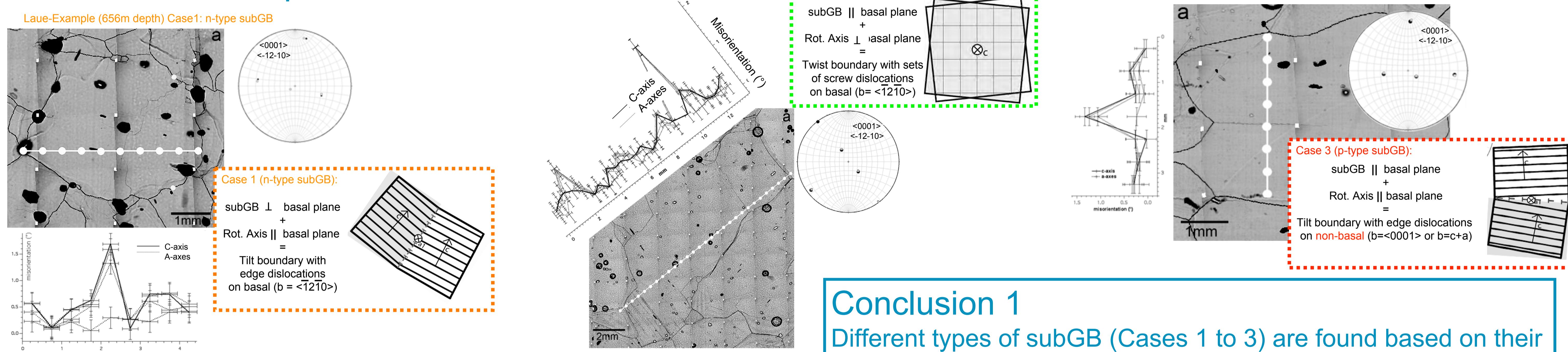


Table 1: Laue data simplified statistics, EDML 18 samples, depths 113 to 2701m. Absolute number frequencies of all subGBs with detectable misorientations ($n_{>0.5^\circ} = 165$) displaying combined information on misorientation rotation axes (columns) and subGB arrangements (lines).

Arrangement:	Rotation Axis: c-axis as rotation axis	rotation axis in basal plane	arbitrary rotation axes
basal plane normal (n and z-type)	0	65 ^[a]	14
basal plane parallel (p-type)	11 ^[b]	45 ^[b]	14
no particular arrangement to basal plane	1	7	8

EBSD Results and Interpretation

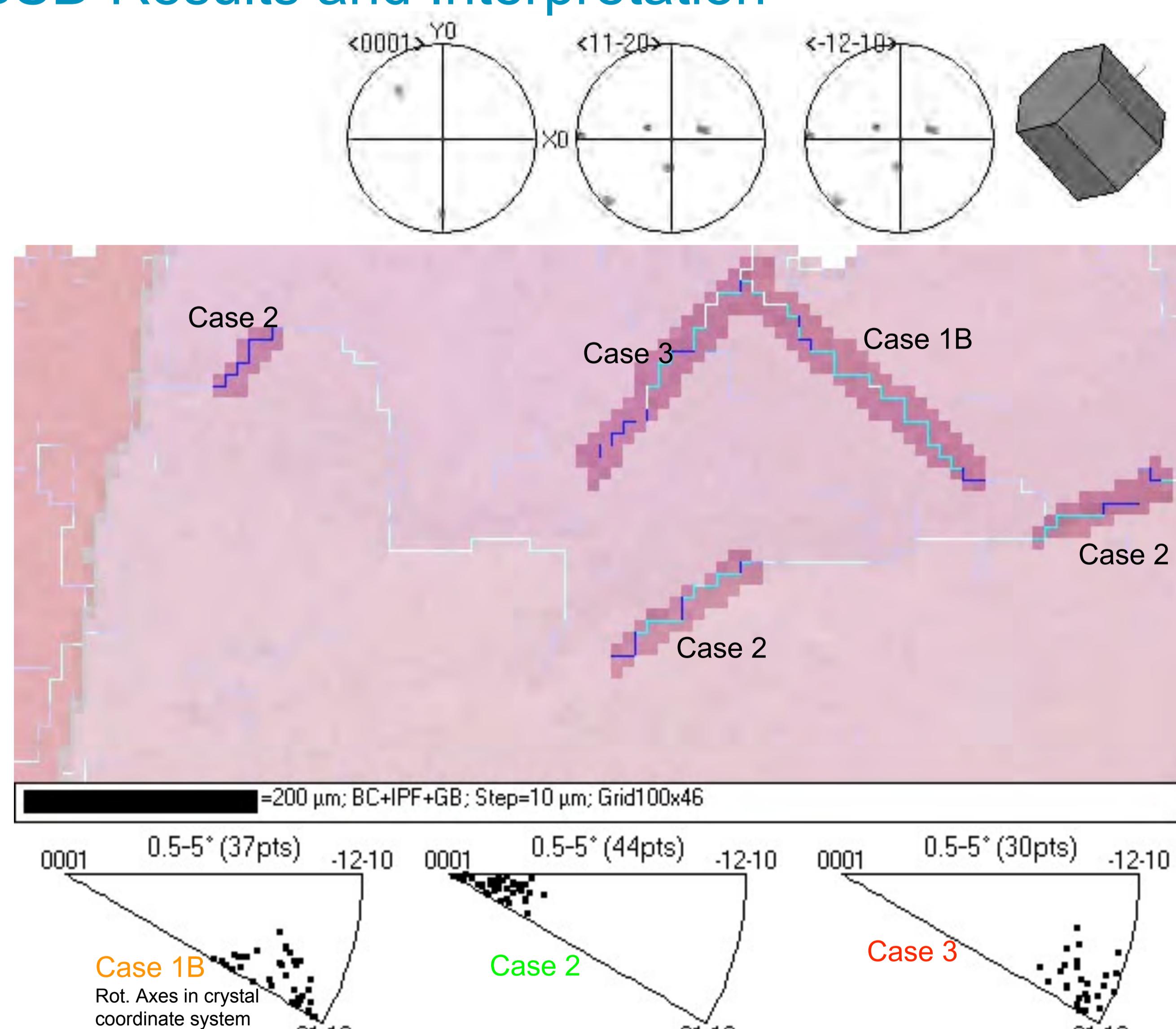


Table 3: EBSD data statistics, EDML 4 samples, 14 EBSD maps, depth 656m. Absolute number frequencies of all subGBs with detectable misorientations ($n_{>0.5^\circ} = 196$) displaying combined information on misorientation rotation axes (columns) and subGB arrangements (lines).

Arrangement:	Rotation Axis: <0001>	<11-20>	<-12-10>	c-axis	a-axis	prism-normal	in basal plane	pyr.-normal	arbitrary rotation axes
basal plane normal (n and z-type)	2	10 ^[d]	19 ^[e]	27 ^[a]	1 ^[f]		14		
basal plane parallel (p-type)	7 ^[b]	8 ^[c]	11 ^[c]	35 ^[c]	2		13		
no particular arrangement to basal plane	7	9	5	14	0		14		

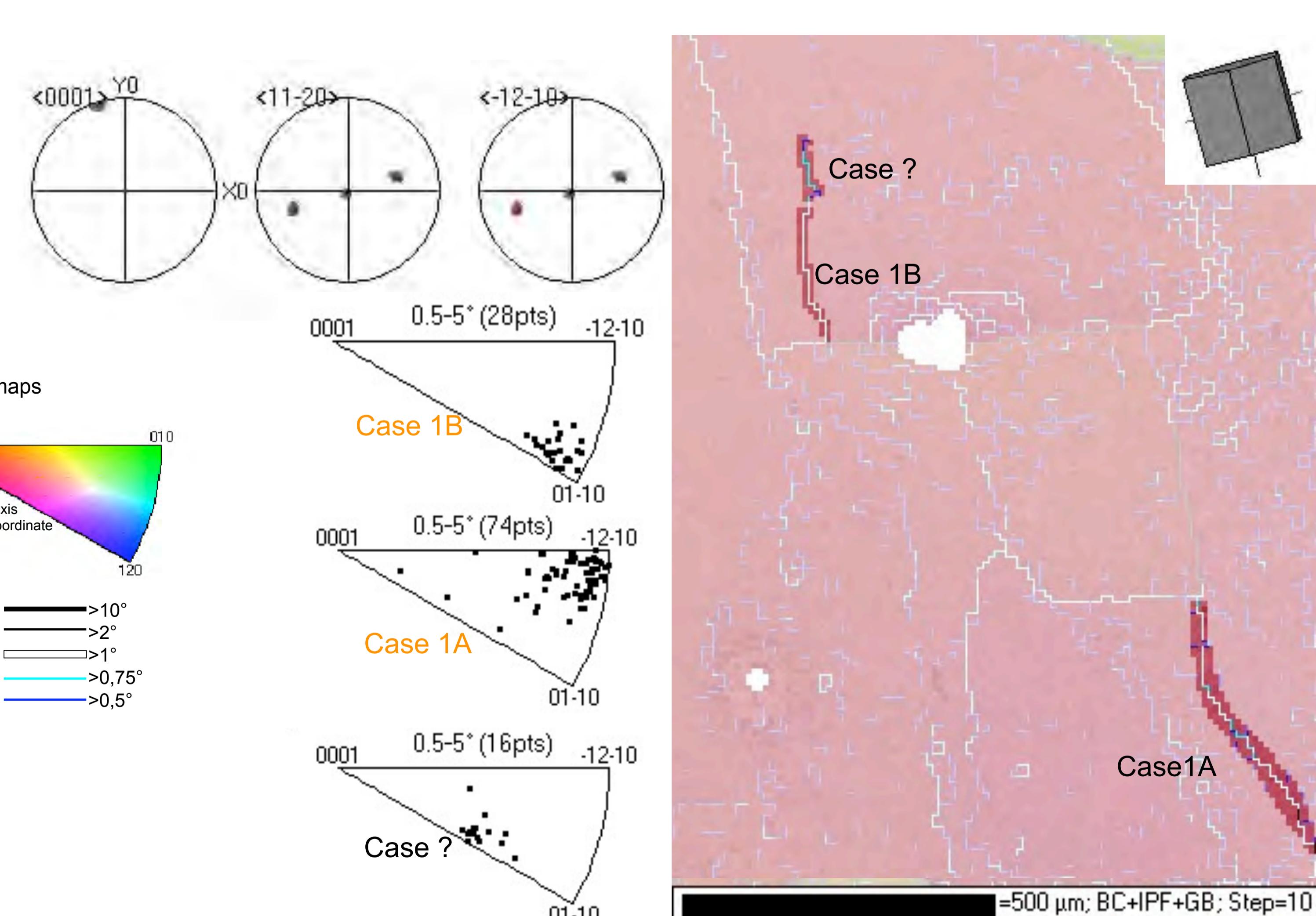
[a] Case 1: tilt boundary with dislocations in the basal plane
[b] Case 2: twist boundary with dislocations in the basal plane
[c] Case 3: tilt boundary with dislocations in a non-basal plane
[d] Case 1A
[e] Case 1B
[f] Case ?

Conclusion 1

Different types of subGB (Cases 1 to 3) are found based on their geometric characteristics. The relevant dislocations to form these subGB types can be deduced. Surprisingly, dislocations gliding on non-basal planes are very frequent (Table 1).

Table 2: EBSD data simplified statistics, EDML 4 samples, 14 EBSD maps, depth 656m. Absolute number frequencies of all subGBs with detectable misorientations ($n_{>0.5^\circ} = 196$) displaying combined information on misorientation rotation axes (columns) and subGB arrangements (lines).

Arrangement:	Rotation Axis: c-axis as rotation axis	rotation axis in basal plane	arbitrary rotation axes
basal plane normal (n and z-type)	2	56 ^[a]	15
basal plane parallel (p-type)	7 ^[b]	54 ^[c]	15
no particular arrangement to basal plane	7	28	14



Conclusion 2

The high frequency of non-basal dislocations is confirmed by EBSD (Table 2). Further different types of tilt boundaries with basal dislocations are observed (Case 1A & B). Surprisingly, mixed boundaries with arbitrary rotation axes can show specific rotation axes close to the pyramidal plane normal (Case ?, Table 3).

References

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